



(12)

EUROPEAN PATENT APPLICATION

(43) Date of publication:
17.03.2004 Bulletin 2004/12

(51) Int Cl.⁷: **G01N 29/06**, G01N 29/26,
G01S 15/89
// G10K11/34, G01S7/52

(21) Application number: **03255786.0**

(22) Date of filing: **16.09.2003**

(84) Designated Contracting States:
**AT BE BG CH CY CZ DE DK EE ES FI FR GB GR
 HU IE IT LI LU MC NL PT RO SE SI SK TR**
 Designated Extension States:
AL LT LV MK

(30) Priority: 16.09.2002 US 244637

(71) Applicant: **GENERAL ELECTRIC COMPANY**
Schenectady, NY 12345 (US)

(72) Inventors:

- Batzinger, Thomas James
Burnt Hills New York 12027 (US)
- Gilmore, Robert Snee
Burnt Hills New York 12027 (US)
- Li, Wei
Nuskayuna New York 12309 (US)
- Nieters, Edward James
Burnt Hills New York 12027 (US)

- Hatfield, William Thomas
Schenectady New York 12309 (US)
- Klaassen Richard, Eugene
West Chester Ohio 45069 (US)
- Barshinger, James Norman
Aaronsburg Pennsylvania 16820 (US)
- Haider, Bruno Hans
Ballston Lake New York 12019 (US)
- Chalek, Carl Lawrence
Glenville New York 12302 (US)
- McEilligott, Robert John
Loveland Ohio 45140 (US)
- Franklin, David Charles
Cincinnati Ohio 45241 (US)

(74) Representative: **Pedder, James Cuthbert et al**
London Patent Operation
General Electric International, Inc.
15 John Adam Street
London WC2N 6LU (GB)

(54) **Phased array ultrasonic inspection method for industrial applications**

(57) A method for inspecting a component (10) includes exciting a number of transducers (12) forming an array (14) to produce an ultrasonic transmission beam (beam) focused into the component. The array and the component are separated by a standoff (18). A number of echo signals are generated using the transducers, and the echo signals are processed in a number of channels. The processing includes both dynamical focus and providing a dynamic aperture (24) on receive, both of

which compensate for refraction of the beam at the component/standoff interface. A single-turn inspection method includes: (a) positioning the array facing the component, (b) exciting the transducers, (c) generating a number of echo signals, (d) changing the relative angular orientation of the array and the component around an axis (26) and repeating steps (b) and (c), and (e) processing the echo signals to form at least one processed echo signal.

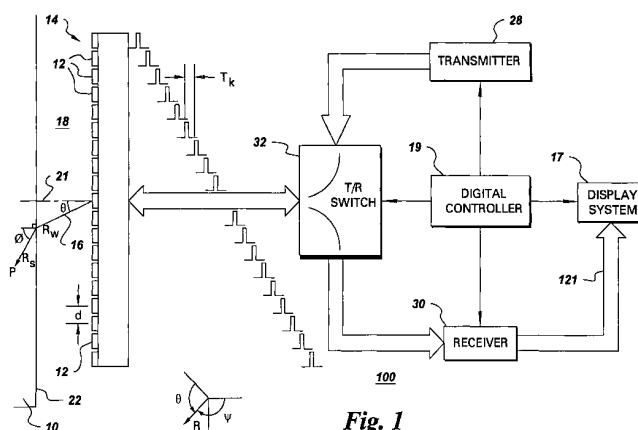


Fig. 1

Description

[0001] The invention relates generally to ultrasonic imaging methods for industrial applications and, more particularly, to improved ultrasonic imaging methods for the detection of defects found in components and structures (collectively termed "components") found in industrial settings using advanced phased array ultrasound systems.

[0002] Both the use of lighter components in industrial applications and the use of industrial components over longer engineering design lives have increased the demand for enhanced nondestructive inspection techniques designed for industrial settings. To meet current demands, it is necessary to detect smaller defects with greater productivity. Medical imaging tools, such as the GE LOGIQ 9 and the GE LOGIQ Book, include many features that would be desirable for industrial applications.

[0003] Conventional ultrasonic inspection systems for industrial applications employ either probes with fixed focus lenses or limited capability phased array imaging techniques. Limitations include performing inspections within the focal depth of field, in the case of the fixed focus lens systems, or within the limits of the phased array system to produce a focused beam. Generally, conventional ultrasonic systems for industrial applications use either a single probe, in pulse echo mode, or a pair of probes, in either a through transmission or pitch and catch mode. These probes can be either unfocused or focused using an attached lens. Industrial inspections requiring high sensitivity over a large depth range are typically accomplished using multiple scans with appropriately focused probes. Such inspections are time consuming due to the multiple scans required. High-sensitivity, large depth range inspections are also performed using a multi-zone approach, in which multi-channel acquisition systems are used to monitor data from multiple probes simultaneously, with each probe monitoring a separate depth within the test component. Conventional ultrasonic inspection systems for industrial applications are typically limited to a single angle beam interrogation of the test component. The angled ultrasonic beam is produced either by affixing the probe to a wedge of material at an angle relative to the test component or by immersion of the probe in a material with a material velocity, which is sufficiently different from that of the test component to cause refraction of the beam.

[0004] Conventional phased array imaging ultrasound systems for industrial inspections typically are limited to beam-forming, with the more advanced of these systems providing dynamic depth focus but incapable of performing dynamic aperture sizing. Dynamic aperture sizing is desirable to control the beam properties.

[0005] It would therefore be desirable to provide an inspection method for industrial applications that provides both dynamic focus and dynamic aperture sizing.

It would further be desirable for the method to compensate for refraction at an interface between a test component and a standoff, for example a water standoff. It would also be desirable to provide an inspection method for industrial applications that compensates for the steering of the ultrasonic transmission beam due to refraction at a test component/standoff interface. In addition, it would be desirable to correct for surface geometry effects caused by a curved test component/standoff interface. To increase productivity, it would also be desirable to provide a single-turn inspection method, so that industrial components can be inspected without time-consuming movement of a probe. It would also be desirable to provide a method to inspect the quality of the product flow through pipes that employs ultrasonic inspection techniques. To decrease inspection time, it would be desirable to employ full-arrayinsonification. Also, for industrial applications, it would be desirable to introduce synchronization of images with the corresponding probe position to advanced ultrasound imaging systems typically employed for medical applications.

[0006] Briefly, in accordance with one embodiment of the present invention, a method of inspecting a component is provided. The inspection method includes exciting a number of transducers forming an array to produce an ultrasonic transmission beam focused into the component along a selected ray path from the array. The array is separated from the component by a standoff with a material velocity v_w . The inspection method further includes generating a number of echo signals using the transducers as receive elements and processing the echo signals in a number of channels. The processing includes dynamically focusing the echo signals along the selected ray path on at least one focal point P in the component. The dynamic focusing comprises adjusting a delay profile to compensate for refraction of the ultrasonic transmission beam at an interface between the component and the standoff and applying the delay profile to the echo signals in the respective channels to generate a number of delayed echo signals. The processing further includes adjusting the number of active receive elements as a function of a range R_s , to provide a dynamic aperture on receive. The adjustment of the number of receive elements comprises compensating for refraction of the ultrasonic transmission beam at the interface between the component and the standoff. The processing also includes summing the delayed echo signals from the active receive elements to generate a focused echo signal.

[0007] Another method embodiment for inspecting a component includes applying a separate excitation pulse to each transducer in the array, to produce an ultrasonic transmission beam focused into the component along a selected ray path. As above, the array is separated from the component by a standoff with a material velocity v_w . The inspection method further includes steering the ultrasonic transmission beam along the selected ray path at an angle Θ relative to a surface nor-

mal. The steering comprises adjusting a transmit delay profile, to compensate for refraction of the ultrasonic transmission beam at the interface between the component and the standoff, and modulating the excitation pulses with the transmit delay profile. The inspection method further includes generating a number of echo signals using the transducers as receive elements and processing the echo signals in a number of channels using a delay profile that comprises a number of receive delays, each receive delay comprising a static receive steering term. The echo signal processing includes adjusting each of the static receive steering terms to compensate for refraction of the ultrasonic transmission beam at the component/standoff interface, applying the delay profile to the echo signals in the respective channels to generate a number of delayed echo signals, and summing the delayed echo signals from the receive elements to generate a steered echo signal.

[0008] A single-turn method embodiment for inspecting a component having an inspection surface is also provided. The single-turn inspection method includes (a) positioning an array of transducers facing the inspection surface of the component, (b) exciting the transducers to produce an ultrasonic transmission beam focused into the component along a selected ray path from the array, (c) generating a number of echo signals using the transducers as receive elements, (d) changing the relative angular orientation of the array and the component around an axis and repeating steps (b) and (c), and (e) processing the echo signals in a number of channels to form at least one processed echo signal.

[0009] A method embodiment for inspecting product flow through a pipe is also provided. This inspection method includes exciting a number of transducers forming an array to transmit ultrasonic energy into the pipe, generating a number of receive signals from the reflected ultrasonic energy, and processing the receive signals in a number of channels. The processing comprises comparing the receive signals to a frequency reference to determine a number of frequency shifts imparted to the reflected ultrasonic energy.

[0010] The invention will now be described in greater detail, by way of example, with reference to the drawings, in which:-

FIG. 1 is a block diagram of an ultrasonic imaging system;

FIG. 2 shows an array and a component separated by a standoff, the component and standoff having different material velocities v_s and v_w , respectively;

FIG. 3 shows a secondary lens effect caused by a standoff between an array of transducers and a component having a curved surface;

FIG. 4 illustrates a single-turn inspection method;

FIG. 5 shows a "stitched" image of a component with and without compensation for a standoff with a material velocity that differs from that of the component;

FIG. 6 illustrates a through-transmission inspection method;

FIG. 7 illustrates a conventional "pitch and catch" inspection technique;

FIG. 8 shows an improved pitch and catch inspection technique using an array of transducers for both pitching and catching;

FIG. 9 illustrates a method of inspecting product flow through a pipe;

FIG. 10 illustrates the simultaneous excitation of each of a first set of transducers in an array; and

FIG. 11 illustrates another improved pitch and catch inspection technique using a single array of transducers for both pitching and catching.

A. Dynamic Aperture and Dynamic Focus

[0011] A method of inspecting a component 10 is described with reference to Figures 1 and 2. The method includes exciting a number of transducers 12 forming an array 14 to produce an ultrasonic transmission beam focused into the component 10 along a selected ray path 16 from the array, as shown in Figure 1, which illustrates an ultrasonic imaging system 100 in block diagram form. Each of the transducers 12 is excited, for example, by a pulse produced by a transmitter 28. As shown in Figure 2, the array 10 is separated from the component 10 by a standoff 18 with a material velocity C_w . Exemplary standoffs 18 include water, other fluids such as oils and glycerine, and a machined wedge (shoe). Examples of shoes (not shown) are solid structures machined to mate with the geometry of the transducer surface, on one side, and the component geometry on the other side. Shoes are often formed of plexiglass or Lucite. The method further includes generating a number of echo signals using the transducers 12 as receive elements 12, and processing the echo signals in a number of channels. For example, the ultrasonic energy reflected back to the array 14 is converted to an electrical signal (echo signal) by each of the transducers 12 and applied separately to a receiver 30 through a set of switches 32. For the exemplary system shown in Figure 1, the transmitter 28, receiver 30, and switches 32 are controlled by a digital controller 19 responsive to commands input by an operator.

[0012] The processing includes dynamically focusing the echo signals along the selected ray path 16 on at least one focal point P in the component 10. The dynam-

ic focusing includes adjusting a delay profile comprising a number of receive delays to compensate for refraction of the ultrasonic transmission beam at the interface 22 between the component 10 and the standoff 18. Exemplary receive delays include time and/or phase delays, which are indicated in Figure 1 by (T_k). In the case of a linear array 14, each of the receive delays includes a beam focusing time delay that changes during reception of the echo to provide dynamic focusing of the received ultrasonic energy at the range from which the echo signal emanates. As explained in commonly assigned U. S. Patent No. 5,235,982, O'Donnell, entitled "Dynamic transmit focusing of a steered ultrasonic beam," which is incorporated herein by reference, the delays may ordinarily be expressed as:

$$T_k = (k - (N - 1)/2)^2 d^2 \cos^2 \Theta / 2Rv,$$

where R is the range of the focal point P from the center of the array 14, v is the material velocity of the component 10, and Θ is the angle of incidence for the beam 16 relative to a surface normal 21. However, this expression does not compensate for refraction at a component/standoff interface 22. An exemplary adjustment of this expression to compensate for the refraction across interface 22 is:

$$T_k = [k - (N - 1)/2]^2 d^2 \cos \Theta / [2(R_w V_w + R_s V_s)],$$

where R_w is the length of the beam extending along the central beam axis 16 in the standoff 18, v_w is the material velocity in the standoff 18, R_s is the length of the beam extending along the central beam axis 16 in the component 10, and v_s is the material velocity in the component 10. The delay profile is applied to the echo signals in the respective channels to generate a number of delayed echo signals. For example, receiver 30 samples the echo signals at a succession of ranges R_s (R_w is constant for a given angle Θ) and provides the proper receive delays to dynamically focus at points P along the sampled beam. Thus, each emission of an ultrasonic pulse results in the acquisition of a series of echo signal samples that represent the amount of reflected sound from a corresponding series of points P located along the ultrasonic receive beam.

[0013] To provide a dynamic aperture 24 on receive, the processing further includes adjusting the number of active receive elements as a function of a range R_s . (R_w is constant for a given incident angle Θ) As used here, the phrase "active receive element" 12 indicates a transducer from which the echo receive signal is included in the overall focused echo signal. Exemplary active receive elements are indicated in Figure 2 by shading. In contrast, the echo signals from inactive receive elements 12 are neglected when calculating the focused echo signal. The adjustment of the number of receive

elements 12 includes compensating for refraction of the ultrasonic transmission beam at the interface 22 between the component 10 and the standoff 18. For example, for an ultrasonic beam 16 incident on a component with no significant change in material velocity at the surface of the component, to maintain a constant focal number F, the aperture width A is adjusted according to the formula $F = R/A$. So for this conventional example, as the range R increases, A must also be increased to maintain a constant focal number F. In other words, the delayed echo signals of more active receive elements 12 contribute to the focused echo signal. As noted above, the ultrasonic transmission beam 16 is refracted at the interface 22 of the component 10 and the standoff 18, due to the mismatch in material velocities V_w and V_s . To compensate for the refraction, adjustment of the aperture width A is performed according to the expression:

$$F = [R_w + R_s(V_s/V_w)]/A.$$

[0014] In addition to the dynamic focusing and dynamic aperture sizing described above, the processing further includes summing the delayed echo signals from all of the active receive elements to generate a focused echo signal. For example, the delayed echo signals are summed in receiver 30 to form the focused echo signal, which may be employed, for example, to produce a pixel or a line in an image on a display 17.

[0015] Although the provision of dynamic aperturing and dynamic focusing has been described with respect to a component 10 and an array 14 separated by a standoff 18 with a material velocity mismatch, this combination is also applicable to contact ultrasonic inspection of a component 10, for example, for industrial inspection applications. By "contact," it is meant that the array 14 is placed in direct contact with the component 10. (Not shown in Figures 1 and 2.) However, where there is no standoff 18, there is no material velocity mismatch at the surface 22 of the component 10, and hence no refraction at the surface 22 of the component 10. Consequently, the dynamic aperturing and focusing are not corrected to compensate for refraction at the surface 22 of the component for ultrasonic inspection of a component 10 without a standoff 18. Dynamic aperture sizing and focusing in the absence of a standoff 18 are described, for example, in commonly assigned U.S. Patent No. 4,180,790, Charles E. Thomas, entitled "Dynamic Array Aperture and Focus Control for Ultrasonic Imaging Systems," which is incorporated by reference herein.

[0016] Beneficially, the use of a dynamic aperture coupled with dynamic focusing enables controlling desired focal properties over the entire depth of inspection.

[0017] It is desirable for the array 14 to contain a large number of transducers 12, for example 128 or 1024, to provide a large inspection area. To enable the use of a large number of transducers without a corresponding in-

crease in the number of channels and to reduce the number of switches 32 needed, the transducers 12 may be multiplexed, for example as described in commonly assigned U.S. patent No. 5,329,930, Thomas et al., entitled "Phased Array Sector Scanner with Multiplexed Acoustic Transducer Elements," which is incorporated by reference herein. Beneficially, the use of 128 transducers 12 independently or 1024 transducers 12 via multiplexing facilitates improved productivity and inspection flexibility relative to conventional industrial ultrasonic inspection methods.

[0018] It is desirable to direct or steer the ultrasonic beam to move the beam through a set of angles $\ominus$ to scan the component 10. According to a more particular embodiment, a separate excitation signal pulse is applied to each of the transducers, to drive each of the transducers 12 with separate voltages (apodizing). For this embodiment, which is illustrated in Figure 2, the inspection method further includes steering the ultrasonic transmission beam along the selected ray path 16 at an angle $\ominus$ relative to the surface normal 21. The steering includes adjusting a transmit delay profile to compensate for refraction of the ultrasonic transmission beam at the interface 22. The transmit delay profile comprises a set of transmit delays, and each transmit delay includes a static steering term. Exemplary transmit delays include time and/or phase delays, which are also indicated in Figure 1 by (T_k) . The steering further includes modulating the excitation signal pulses with the transmit delay profile. For example, transmitter 28 imparts a transmit delay to each of the signal pulses applied to the successive transducer elements 12. If the transmit delay is zero ($T_k=0$), all of the transducer elements 12 are energized simultaneously, and the resulting ultrasonic beam is directed normal to the interface 22 between the standoff 18 and the component 10. To steer the ultrasonic beam, the transmit delay T_k that is added to the respective k th signal pulse from one end of the array 14 ($k=1$) to the other end ($k=N$) can be expressed as:

$$T_k(\ominus) = (d/v_w) \sin \ominus (k-1),$$

where d is the distance between transducer elements 12, as shown in Figure 1. This transmit delay profile (T_k) compensates for the refraction of the steered ultrasonic beam at the interface 22.

[0019] In addition to steering the ultrasonic beam on transmit, the inspection method also includes forming a steered focused echo signal by application of the delay profile to the echo signals in the respective channels to generate the delayed echo signals (steering on receive). For this steering embodiment, the delay profile includes a set of receive delays, and each receive delay comprises a static receive steering term. Each of the static receive steering terms is adjusted to compensate for refraction at the interface. Each of the static receive steering terms for reception is the same delay $T_k(\ominus)$ as the

transmit delay explained above. Although only one angle ($\ominus$) is indicated, those skilled in the art will recognize that the ultrasonic beam may also be steered along multiple angles ($\ominus, \psi$) with respect to a common axis 21. This embodiment encompasses both single-angle ($\ominus$) and multi-angle ($\ominus, \psi$) steering.

[0020] In order to scan the component 10 at various depths R_s , multiple transmits are used. For this particular embodiment of the inspection method, a separate signal pulse is applied to each of the transducers 12 at each of a number of successive excitation time intervals t_i , and the generation of the echo signals is performed for each of the successive excitation time intervals t_i . For example, at a first time interval t_1 , each of the transducers 12 is separately driven, and a first set of echo signals is generated. At a second time interval t_2 , each of the transducers 12 is separately driven, and a second set of echo signals is generated, and so on. For this embodiment, the echo signals are dynamically focused along the selected ray path 16 at a number of focal points P_i at various ranges R_i during each successive i th one of the excitation time intervals t_i . The dynamic focusing at focal points P_i includes adjusting a respective delay profile (T_{ki}) comprising a number of receive delays T_{ki} to compensate for refraction of the ultrasonic transmission beam at the interface 22 between the component 10 and the standoff 18. These adjustments are performed as described above. In addition to dynamically focusing for each of the time intervals t_i , for the inspection method of this particular embodiment, the dynamic aperturing is performed for each time interval t_i . More particularly, the number of active receive elements is adjusted for each of the successive excitation time intervals t_i as a function of the range R_i , to compensate for refraction of the ultrasonic transmission beam at the interface 22 between the component 10 and the standoff 18. To generate a focused echo signal for each range R_i , the delayed echo signals from all of the active receive elements are summed, for example in receiver 30, for each of the successive excitation time intervals.

[0021] To display the resulting image data, it is useful to assemble (stitch) the image data from multiple depths into a single frame (image). This single frame is displayed using display system 17. Image stitching is known in the art and hence will not be described in detail here. However, it should be noted that when the imaging is done through a standoff 18, a conventional medical ultrasonic imaging system will distort the image due to the material velocity difference between the standoff 18 (v_w) and the component 10 (v_s). This distortion is shown in Figure 5. As shown, the uncompensated image distorts the portion of the image corresponding to the standoff 18 by the ratio v_s/v_w . To compensate for the material velocity mismatch across the interface 22, the portion of the image corresponding to the standoff 18 is reduced by the ratio v_s/v_w , according to a particular embodiment. The compensated image is also shown in Figure 5. Another correction is to remove the portion of the

image corresponding to the standoff 18. Either of these corrections may be performed, for example, using the imaging software applied to display system 17.

B. Steering

[0022] Another method embodiment of the present invention is also described with reference to Figures 1 and 2. The method of inspecting a component 10 includes applying a separate excitation pulse to each transducer 12 forming array 14, to produce an ultrasonic transmission beam focused into the component 10 along a selected ray path 16 from the array 14. As shown in Figure 2, the array 14 is separated from the component 10 by a standoff 18 with a material velocity c_w . The method further includes steering the ultrasonic transmission beam along the selected ray path at an angle Θ relative to the surface normal 21. The steering includes adjusting a transmit delay profile (T_k) to compensate for refraction of the ultrasonic transmission beam at interface 22, as discussed above. The steering further includes modulating the excitation pulses with the transmit delay profile (T_k), as discussed above. The inspection method further includes generating a number of echo signals using the transducers 12 as receive elements 12, and processing the echo signals in a number of channels using a delay profile. The delay profile comprises a set of receive delays, and each receive delay has a static receive steering term, as discussed above. The processing includes adjusting each of the static receive steering terms to compensate for refraction of the ultrasonic transmission beam at the interface 22 between the component 10 and the standoff 18, applying the delay profile (T_k) to the echo signals in the respective channels to generate a number of delayed echo signals, and summing the delayed echo signals from the receive elements 12 to generate a steered echo signal. As discussed above with respect to the first embodiment, the echo signals are generated by each of the transducers 12 and applied separately to a receiver 30 through a set of switches 32. Each of the receive delays $T_k(\Theta)$ is applied to the echo signal of the respective kth transducer 12 to form the respective delayed echo signal. The delayed echo signals are summed in the receiver 30.

[0023] In addition to steering the ultrasonic beam, it is useful to provide dynamic aperture sizing for inspection of industrial components. Accordingly, for a more particular embodiment the processing step further includes adjusting the number of active receive elements 12 as a function of a range R to provide a dynamic aperture 24 on receive. As noted above, an active receive element 12 is a transducer 12 from which the echo receive signal is included in the overall steered echo signal. In contrast, the echo signals from inactive receive elements 12 are neglected when calculating the steered echo signal. Because of the material velocity mismatch across interface 22, the adjustment of the number of receive elements 12 includes compensating for refraction

of the ultrasonic transmission beam at the interface 22. For example, adjustment of the aperture width A is performed according to the expression: $F=[R_w + R_s(v_s/v_w)]/A$, as discussed above. As noted above, R_w is the length of the beam extending along the central beam axis 16 in the standoff 18, C_w is the material velocity in the standoff 18, R_s is the length of the beam extending along the central beam axis 16 in the component 10, and v_s is the material velocity in the component 10. R_w and R_s are exemplarily indicated in Figure 2. For this steering plus dynamic aperture embodiment, the summing step comprises summing the delayed echo signals from all of the active receive elements 12 to generate the steered echo signal.

[0024] Although only one angle (Θ) is indicated, those skilled in the art will recognize that the ultrasonic beam may also be steered with respect to multiple angles (Θ , Ψ). This embodiment encompasses both single-angle (Θ) and multi-angle (Θ , Ψ) steering.

[0025] In addition to steering longitudinal waves, it would also be desirable to inspect industrial components by steering other wave modes. Industrial components 10, such as forgings, billets, welds (weldments) and other solids, support shear and surface wave propagation. Briefly, acoustic waves have three main propagation modes, longitudinal, shear and surface waves. Additional propagation modes include Lamb waves, Stonely waves, and extensional waves. The velocity of the shear wave v_{sh} is about one half that of the longitudinal wave v_L ($v_{sh} \sim 0.5 v_L$), and the velocity of the surface wave v_{su} is about 0.9 times that of the shear wave ($v_{su} \sim 0.9 v_{sh}$). As discussed above with respect to Figure 2, an ultrasonic beam incident on a standoff 18/component 10 interface 22 (for example a water/steel interface 22) at an angle Θ is refracted in the component at a refracted angle ϕ , and the relationship between the incident and refracted angles is governed by Snell's Law: $\sin \Theta / \sin \phi = v_w / v_s$. More particularly, each of the three modes has a distinct refracted angle ϕ . Namely, the longitudinal wave is refracted at an angle ϕ_L , which is governed by $\sin \Theta / \sin \phi_L = v_w / v_L$, the shear wave is refracted at an angle ϕ_{sh} , which is determined by: $\sin \Theta / \sin \phi_{sh} = v_w / v_{sh}$, and the surface wave is refracted at an angle ϕ_{su} , which is determined by $\sin \Theta / \sin \phi_{su} = v_w / v_{su}$. As the angle of incidence Θ increases, the refracted angles ϕ_L and ϕ_{sh} increase until the respective critical angles $\phi_L = 90^\circ$ and $\phi_{sh} = 90^\circ$ are reached, at which point the respective longitudinal and shear modes no longer propagate in the component 10. The corresponding critical values of the incident angle Θ are determined by Snell's Law and vary for the longitudinal and shear modes, due to the different velocities of the two modes v_L and v_{sh} .

[0026] As noted above, industrial components 10 support shear and surface wave propagation. Accordingly, for another particular embodiment of the inspection method, a separate excitation pulse is applied to each of the transducers 12 to produce a shear wave ultrasonic transmission beam focused into the component

10. Beneficially, a shear wave has a wavelength λ_{sh} equal to about half the wavelength λ_L of a longitudinal wave at the same frequency, permitting greater resolution of defects. Moreover, if the incident angle Θ exceeds the first critical angle ϕ_L , the longitudinal wave does not propagate in the component 10 and use of the shear wave permits inspection of the component at the desired angle Θ without erroneous longitudinal wave signals interfering with the ultrasonic inspection. Similarly, for another particular embodiment of the inspection method, a separate excitation pulse is applied to each of the transducers 12 to produce a surface wave ultrasonic transmission beam along the surface 22 of the component. Beneficially, ultrasonic inspection of industrial components using surface waves facilitates inspection of the surface 22 of the component, including detection of flaws located on the surface 22 of the component 10 (surface flaws). Conventional ultrasonic inspection employs longitudinal waves and hence is a volume inspection tool. Surface wave modes enhance surface flaw detection and inspection capabilities.

[0027] It will be recognized by those skilled in the art that the other inspection techniques described herein are also advantageously combined with these shear and surface wave mode inspections.

C. Surface Geometry

[0028] A method of inspecting a component 10 along a curved surface 22 of the component 10, for example, a conical, cylindrical or compound radii surface 22, and across a standoff 18 with a material velocity c_w is described with reference to Figures 1 and 3. Because of the mismatch of material velocities v_w in the standoff 18 and v_s in the component 10, a curved interface 22 produces a secondary lens effect via refraction, with the standoff 18 functioning like a lens, changing the characteristics of the ultrasonic beam. This secondary lens effect is illustrated in Figure 3 and degrades the resulting image. This inspection method embodiment corrects for the secondary lens effect and includes adjusting a transmit delay profile to compensate for at least one surface geometry effect. The transmit delay profile comprises a set of transmit delays T_k , and each of the transmit delays has a static surface geometry term, which is determined using Fermat's equations to calculate the delay required to have energy from each element 12 arrive at a desired focal point P in phase. The method further includes modulating a number of excitation signal pulses with the transmit delay profile (T_k). More particularly, the transmitter 28 imparts each of the transmit delays T_k to the respective kth excitation signal pulse from one end of the array 14 ($k=1$) to the other end ($k=N$). The method further includes applying a separate one of each of the modulated excitation signal pulses to each of the transducers 12 forming array 14. The array 14 is separated a distance R_w from the component 10. In this manner, an ultrasonic transmission beam is produced that is fo-

cused into the component 10 along a selected ray path 16 from the array 14. Via the static surface geometry term, application of the transmit delays T_k corrects for the secondary lens effect upon transmit. The inspection method further includes generating a number of echo signals using the transducers 12 as receive elements 12 and processing the echo signals in a number of channels

[0029] In addition to correcting for the secondary lens effect upon transmit, the inspection method also corrects for the secondary lens effect on receive. Accordingly, the processing of the echo signal includes applying a delay profile to the echo signals in the respective channels to generate a number of delayed echo signals that compensate for the at least one surface geometry effect. Similar to the transmit delay profile, the delay profile comprises a set of receive delays (T_k), and each of the receive delays includes a static surface geometry term, which is also determined using Fermat's equations to calculate the delay required to have energy from each element 12 arrive at a desired focal point P in phase. More particularly, the static surface geometry terms are the same for both transmission and reception. More particularly, the receive delays T_k are applied to the echo signals from the respective kth receive elements 12 by receiver 30 under the control of digital controller 19.

[0030] The processing of the echo signals further includes summing the delayed echo signals from the receive elements 12 to generate a surface geometry effect compensated echo signal. The echo signals are summed, for example, in receiver 30 under the control of digital controller 19.

D. Single Turn Inspection

[0031] Industrial applications typically involve inspection of numerous components 10, such as billets and forgings. Accordingly, an efficient inspection process is critical to reducing inspection time and costs. In order to enhance inspection efficiency, a single-turn method embodiment is provided, for inspecting a component 10 having an inspection surface 22. The single-turn inspection method is described with reference to Figure 4 and includes positioning an array 14 of transducers 12 facing the inspection surface 22 of the component 10, as shown for example in Figure 4. The array 14 may face the inspection surface 22 either directly or across a standoff 18. In addition, the array 14 may be radially or axially aligned with the component 10. In Figure 4, the arrays 14 marked "R" and "A" are respectively radially and axially aligned with the component 10. In addition, an array 14 may also be formed to extend both radially and axially along the component 10, for example arranged in a right angle (not shown). The single-turn inspection method further includes exciting the transducers 12 to produce an ultrasonic transmission beam focused into the component 10 along a selected ray path 16 from the array 14. A number of echo signals are gen-

erated using the transducers 12 as receive elements 12. The single-turn inspection method further includes changing the relative angular orientation of the array and the component around an axis 26 and repeating the steps of exciting the transducers 12 and generating a number of echo signals. The relative angular orientation of the array 14 and component 10 is changed either by rotating the array 14 or by rotating the component 10 around the axis 26. The echo signals are processed in a number of channels to form at least one processed echo signal. Although the processing step is listed here as following the rotation of the array 14 around the axis 26, it should be understood that this order encompasses both sequential and collective processing. For sequential processing, the array 14 is satisfactorily positioned, the transducers 12 are activated, a set of echo signals is generated and processed. The array 14 is then rotated and the activation, generation and processing steps are repeated for a second set of echo signals, etc. Similarly, for collective processing, several sets of echo signals are generated for each angular increment of the array 14 about axis 26, and the sets of echo signals are then processed. The resulting processed echo signals are displayed, either as separate frames, or stitched together to form a single image of the components.

[0032] Beneficially, by inspecting the component 10 at a number of angular increments about the axis 26, translational movement of the array 14 across the component surface 22 can be avoided, increasing the overall efficiency of the inspection process. According to a particular embodiment of the single-turn method, the processed echo signals corresponding to a final image of the component 10 are obtained with the relative orientation of the array 14 and the component 10 constrained to rotations around the axis 26. By "constrained," it is meant that the final image is obtained at one or more rotational orientations of the array 14 (or component 10) around the axis 26, with no other repositioning of the array 14 relative to the component 10. For example, no translational movement of the array 14 relative to the components 10 is necessary for this embodiment. Desirably, for this embodiment, the array 14 is large enough to extend over the area of interest of the component 14, such that the entire area of interest is scanned by rotating the array 14 around the axis 26. For example, either a single large array or several smaller arrays grouped together are used. Beneficially, this embodiment avoids time-consuming and cumbersome repositioning of either the array 14 or the component 10.

[0033] According to a more particular embodiment applicable to components 10 with a curved inspection surface 22 (not shown in Figure 4), the positioning step further includes contouring the array 14 to the curved inspection surface 22, either directly or through a stand-off 18.

E. Through Transmission

[0034] In addition to single-array inspection, a component 10 may also be inspected by positioning the component 10 between a transmit array 14 and a receive array 14, as illustrated in Figure 6. Conventionally, single ultrasound probes (not shown) are used to inspect a component 10 via through transmission ultrasound inspection. These probes are moved several times to scan the component. Beneficially, using arrays 14 for transmission and reception facilitates scanning the component 10 electronically, thereby eliminating time-consuming mechanical movement of the inspection equipment over the component 10

F. Pitch and Catch

[0035] Another conventional inspection technique is illustrated in Figure 7. As shown, an ultrasound transmission beam is "pitched" into an inspection component 10 by a first probe 42 and "caught" by a second probe 42. This technique is employed for crack-tip diffraction detection. The configuration shown is used to detect the base and tip of a crack 40 in component 10 and, from this information, to size the crack 40. However, this technique requires mechanical manipulation of the probes 42 and hence is relatively slow and cumbersome. Replacing the individual probes 42 with arrays 14 of transducers 12 improves upon the technique described with reference to Figure 7. Figures 8 and 11 illustrate an improved "pitch and catch" inspection method for which a single array 14 is used for both pitching and catching. More particularly, at least one subset of the transducers 12 in the array 14 is energized for transmission of the ultrasonic beam, and at least one subset of the transducers 12 receives the reflected ultrasonic energy. The respective transmit and receive subsets of transducers 12 are indicated in Figures 8 and 11 by "T" and "R." As shown in Figure 8, one subset of transducers 12 may be used on transmit, and one subset may be used on receive. For the embodiment of Figure 11, one subset of transducers 12 is used on transmit, whereas two subsets are used on receive. This single-array pitch and catch embodiment is not limited to the specific configurations illustrated in Figures 8 and 11 but rather encompasses any arrangement of a single array 14 for which at least one set of transducers form a beam on transmission and at least one other set of transducers 12 receive a reflected beam from the test component 10.

G. Doppler

[0036] It is known to use ultrasound to measure blood flow and would be desirable to extend ultrasound techniques developed to monitor blood flow to industrial applications, such as monitoring product flow through tubing or pipes (for example chemical feed pipes) or through instrumentation pipes (used, for example, for

heat exchanger flow). Pipes, tubing, and other vessels through which products flow in industrial applications are collectively termed "pipes" herein. Inspection of product flow through pipes is desirable because deposits (or build-up) on pipe walls can restrict and/or perturb product flow through the pipes. In addition, heat exchangers can plug or foul causing flow restrictions. Ultrasound desirably provides a nondestructive, noninvasive inspection method for detecting and monitoring such problems.

[0037] A method of inspecting product flow through a pipe 50 is described with reference to Figure 9. The method includes exciting a number of transducers 12 forming an array 14 to transmit ultrasonic energy into the pipe 50. For example, the transducers 12 are excited by transmitter 28 through T/R (transmit/receive) switches 32 under control of controller 19. It should be noted that although the array 14 is depicted in Figure 9 as being in contact with the pipe 50, the array 14 and pipe 50 may also be separated by a standoff, for example by water, another liquid suitable for coupling the ultrasonic energy to the pipe 50 and array 14, or a shoe (not shown). The method further includes generating a number of receive signals from reflected ultrasonic energy and processing the receive signals in a number of channels. The receive signals are generated by the transducers 12 acting as receive elements 12, for the embodiment shown in Figure 9. The processing includes comparing the receive signals to a frequency reference to determine a number of frequency shifts imparted to the reflected ultrasonic energy. The processing is performed, for example, by receiver 30 which is controlled by digital controller 19. According to a more particular embodiment, the processing further includes producing an image of the product flow through the pipe 50. For the embodiment of Figure 9, the image is displayed on display 17 using known imaging software (not shown). By imaging the product flow through the pipe, flow restrictions caused by deposits on pipe walls can be detected and monitored.

[0038] For another embodiment, the inspection method further includes converting the frequency shifts to an audible output. For example, the frequency shifts are converted to an audible output, which is transmitted over at least one speaker 44, using known audio software (not shown) such as provided in the GE LOGIQ 9. Converting the frequency shifts to an audible output, provides a quick means for detection by an operator of a problem with the product flow through the pipe.

H. Full Array Insonification

[0039] To enhance the signal-to-noise ratio for ultrasonic inspection of industrial components, another industrial ultrasonic inspection method incorporates full array insonification. This method of inspecting a component 10 is described with reference to Figure 10. The inspection method includes simultaneously exciting a

first set of transducers 12 in an array 14, as exemplarily shown in Figure 10. The exemplary first set of transducers 12 is indicated by the shaded transducers 12. The signal-to-noise ratio increases with the number of transducers 12 included in this first set. According to a particular embodiment, the first set of transducers 12 includes all of the transducers forming the array 14. In other words, for this particular embodiment, each of the transducers 12 forming the array 14 is excited simultaneously, thereby providing full array insonification. The first set of transducers is excited, for example, by transmitter 28, under the control of digital controller 19.

[0040] The inspection method further includes receiving a set of backscattered ultrasound signals from the component 10 using a second set of transducers 12 in the array as receive elements 12 and generating a plurality of receive signals from the backscattered ultrasound signals using the receive elements 12. According to a particular embodiment, the second set of transducers 12 includes all of the transducers 12 forming the array 14. The method further includes processing the receive signals to form a set of beam form image data. The receive signals are processed, for example by receiver 30, under the control of digital controller 19. These processing steps are known, and exemplary processing steps are described in commonly assigned U.S. patent No. 6,048,315, Chiao et al., entitled "Method and Apparatus for Ultrasonic Synthetic transmit Aperture Imaging Using Orthogonal Complementary Codes," which is incorporated by reference herein.

[0041] By simultaneously exciting a first set of the transducers 12, an entire region of interest within the component 10 is insonified, eliminating a need to electronically scan the component 10 via the consecutive excitation of the transducers 12 forming the array 14. In this manner, the method illustrated in Figure 10 increases the speed at which inspection data can be obtained, relative to consecutive driving of the transducers 12 forming an inspection array 14. The corresponding reduction in imaging (and hence inspection) time enhances productivity, which is particularly beneficial in industrial settings. Application of this method embodiment to inspect billets is beneficial, in that a billet 10 is fully insonified by driving the first set of transducers 12 once, reducing the inspection time relative to consecutive firing of the transducers 12.

I. Image Location

[0042] Ultrasound inspection systems for medical applications are advanced and provide a number of desirable features for industrial applications, such as dynamic focusing, dynamic aperture, steering, and Doppler frequency shifts. Examples of advanced ultrasonic inspection systems used for medical applications include the GE LOGIQ 9 and the GE LOGIQ Book. However, ultrasonic inspection systems used for medical applications typically employ a predefined scan rate based on an ar-

bitrary timing reference, which triggers a new image forming sequence. By "arbitrary," it is meant that the timing reference is not linked to position of the array. However, for industrial applications, it is desirable to identify the position at which a given frame (image) was acquired, in order to fully characterize the component 10 after inspection. Accordingly, the inspection methods described above preferably acquire an image (frame) synchronous to the relative position between the array 14 and the component being inspected. More particularly, the timing reference employed is selected for synchronization with the relative position of the array 14 and component 10. For example, encoders may be used to track the position of an axis of motion. A common pulse/position synchronization technique is termed "pulse on position" (or "POP") and applies a TTL level pulse when a mechanical system (here the array 14) arrives at the next data acquisition position.

[0043] As noted above, many ultrasonic inspection systems used for medical applications, such as the GE LOGIQ 9 and the GE LOGIQ Book, typically do not synchronize an image with the position at which it is acquired. Accordingly, for another embodiment of the invention, ultrasonic inspection systems, such as the GE LOGIQ 9 and the GE LOGIQ Book, are modified to acquire data synchronous to the mechanical position of the array 14. More particularly, the timing inputs and outputs are adapted to correlate with position. Exemplary timing inputs to ultrasonic inspection systems used for medical applications include the circuitry for EKG inputs or for foot pedal switches (not shown).

[0044] For the sake of good order, various aspects of the invention are set out in the following clauses:-

1.. A method of inspecting a component (10) comprising:

- (a) exciting a plurality of transducers (12) forming an array (14) to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array, the array being separated from the component by a standoff (18) with a material velocity v_w ;
- (b) generating a plurality of echo signals using the transducers as receive elements (12); and
- (c) processing the echo signals in a plurality of channels, said processing comprising:

- (i) dynamically focusing the echo signals along the selected ray path on at least one focal point P in the component, wherein said dynamic focusing comprises:

- (A) adjusting a delay profile to compensate for refraction of the ultrasonic transmission beam at an interface (22) between the component and the standoff; and

- (B) applying the delay profile to the echo signals in the respective channels to generate a plurality of delayed echo signals;

- (ii) adjusting the number of active receive elements as a function of a range R_s to provide a dynamic aperture (24) on receive, wherein said adjustment of the number of receive elements comprises compensating for refraction of the ultrasonic transmission beam at the interface between the component and the standoff; and
- (iii) summing the delayed echo signals from all of the active receive elements to generate a focused echo signal.

2. The inspection method of Clause 1, wherein said excitement of the transducers (12) comprises applying a separate excitation signal pulse to each of the transducers, said inspection method further comprising:

- (d) steering the ultrasonic transmission beam along the selected ray path at an angle $\ominus$ relative to a surface normal (21), said steering comprising:

- (i) adjusting a transmit delay profile to compensate for refraction of the ultrasonic transmission beam at the interface between the component and the standoff, the transmit delay profile comprising a plurality of transmit delays, with each transmit delay comprising a static steering term, and
- (ii) modulating the excitation signal pulses with the transmit delay profile; and

- (e) forming a steered focused echo signal by said application of the delay profile to the echo signals in the respective channels to generate the delayed echo signals, wherein said delay profile comprises a plurality of receive delays, with each receive delay comprising a static receive steering term, and wherein said adjustment of the delay profile adjusts each of the static receive steering terms to compensate for refraction at the interface.

3. The inspection method of Clause 2, wherein said steering comprises steering the ultrasonic transmission beam along the selected ray path at angles $\ominus$ and ψ

4. The inspection method of Clause 1, wherein:

said excitement of the transducers (12) comprises applying a separate signal pulse to each

of the transducers at each of a plurality of successive excitation time intervals t_i ,
 said generation of the echo signals is performed for each of the successive excitation time intervals t_i ,
 said dynamic focusing comprises dynamically focusing the echo signals along the selected ray path on a plurality of focal points P_i at various ranges R_i during each successive i -th one of the excitation time intervals t_i ,
 said adjustment of the number of active receive elements is performed for each of the successive excitation time intervals t_i as a function of the range R_i , and
 said summation of the delayed echo signals from all of the active receive elements is performed for each of the successive excitation time interval to generate a focused echo signal for the respective range R_i .

5. A method of inspecting a component (10) comprising:

(a) applying a separate excitation pulse to each of a plurality of transducers (12) forming an array (14) to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array, the array being separated from the component by a standoff (18) with a material velocity v_w ;
 (b) steering the ultrasonic transmission beam along the selected ray path at an angle Θ relative to a surface normal (21), said steering comprising:

(i) adjusting a transmit delay profile to compensate for refraction of the ultrasonic transmission beam at the interface between the component and the standoff, the transmit delay profile comprising a plurality of transmit delays, each transmit delay comprising a static steering term, and
 (ii) modulating the excitation pulses with the transmit delay profile;

(c) generating a plurality of echo signals using the transducers as receive elements (12); and
 (d) processing the echo signals in a plurality of channels using a delay profile, the delay profile comprising a plurality of receive delays, each receive delay comprising a static receive steering term, said processing comprising:

(i) adjusting each of the static receive steering terms to compensate for refraction of the ultrasonic transmission beam at the interface between the component and the standoff;

(ii) applying the delay profile to the echo signals in the respective channels to generate a plurality of defayed echo signals; and

(iii) summing the delayed echo signals from the receive elements to generate a steered echo signal.

6. The inspection method of Clause 4, wherein said processing step further comprises:

(iv) adjusting the number of active receive elements (12) as a function of a range R_s to provide a dynamic aperture (24) on receive, wherein said adjustment of the number of receive elements comprises compensating for refraction of the ultrasonic transmission beam at the interface between the component (10) and the standoff (18),

wherein said summing step comprises summing the delayed echo signals from all of the active receive elements to generate the steered echo signal.

7. The inspection method of Clause 5, wherein said steering comprises steering the ultrasonic transmission beam along the selected ray path at angles Θ and ψ .

8. The inspection method of Clause 5, wherein said application step comprises applying a separate excitation pulse to each of the transducers (12) to produce a sheer wave ultrasonic transmission beam focused into the component (10).

9. The inspection method of Clause 5, wherein said application step comprises applying a separate excitation pulse to each of the transducers (12) to produce a surface wave ultrasonic transmission beam focused along the surface (22) of the component (10).

10. A method of inspecting a component (10) along a curved surface (22) of the component and across a standoff (18) with a material velocity v_w , said inspection method comprising:

(a) adjusting a transmit delay profile to compensate for at least one surface geometry effect, the transmit delay profile comprising a plurality of transmit delays, each of the transmit delays comprising a static surface geometry term;
 (b) modulating a plurality of excitation signal pulses with the transmit delay profile;
 (c) applying the modulated excitation signal pulses to a plurality of transducers (12) forming an array (14) separated from the component by

the standoff, to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array;

(d) generating a plurality of echo signals using the transducers as receive elements (12); and
(e) processing the echo signals in a plurality of channels, said processing comprising:

- (i) applying a delay profile to the echo signals in the respective channels to generate a plurality of delayed echo signals that compensate for at least one surface geometry effect, the delay profile comprising a plurality of receive delays, each of the receive delays comprising a static surface geometry term; and
- (ii) summing the delayed echo signals from the receive elements to generate a surface geometry effect compensated echo signal.

11. A single-turn method of inspecting a component (10) having an inspection surface (22), said single-turn inspection method comprising:

- (a) positioning an array (14) of transducers (12) facing the inspection surface of the component;
- (b) exciting the transducers to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array;
- (c) generating a plurality of echo signals using the transducers as receive elements (12);
- (d) changing the relative angular orientation of the array and the component around an axis (26) and repeating steps (b) and (c); and
- (e) processing the echo signals in a plurality of channels to form at least one processed echo signal.

12. The single-turn inspection method of Clause 9, wherein the processed echo signals corresponding to a final image of the component (10) are obtained with the relative orientation of the array (14) and the component constrained to rotation around the axis (26).

13. The single-turn inspection method of Clause 9, wherein the component has a curved inspection surface (22), and wherein said positioning step further comprises contouring the array (14) to the curved inspection surface.

14. A method of inspecting product flow through a pipe (50), said method comprising:

- (a) exciting a plurality of transducers (12) forming an array (14) to transmit ultrasonic energy into the pipe;

(b) generating a plurality of receive signals from reflected ultrasonic energy; and

(c) processing the receive signals in a plurality of channels, said processing comprising comparing the receive signals to a frequency reference to determine a plurality of frequency shifts imparted to the reflected ultrasonic energy.

15. The method of Clause 14, wherein said processing further comprises producing an image of the product flow through the pipe.

16. The method of Clause 14, further comprising:

- (d) converting the frequency shifts to an audible output.

17. A method of inspecting a component (10) comprising:

- (a) simultaneously exciting a first set of transducers (12) in an array (14);
- (b) receiving a plurality of backscattered ultrasound signals from the component using a second set of transducers (12) in the array as receive elements (12);
- (c) generating a plurality of receive signals from the backscattered ultrasound signals using the receive elements; and
- (d) processing the receive signals to form a set of beam form image data.

18. The method of Clause 17, wherein the second set of transducers (12) includes all of the transducers forming the array (14).

19. The method of Clause 18, wherein the first set of transducers (12) includes all of the transducers forming the array (14).

20. A method of inspecting a component (10) using a single array (14) of transducers (12) comprising:

- (a) exciting at least one transmit set of the transducers (12) to produce an ultrasonic transmission beam incident on an inspection surface (22) of the component at an angle $\ominus$ relative to a surface normal (21);
- (b) receiving a plurality of backscattered ultrasound signals from the component using at least one receive set of transducers (12) in the array as receive elements (12), each of the receive and transmit sets being centered at a unique position on the array;
- (c) generating a plurality of echo signals from the back-scattered ultrasound signals; and
- (d) processing the echo signals in a plurality of channels () to form a set of beam form image

data.

Claims

1. A method of inspecting a component (10) comprising:

(a) exciting a plurality of transducers (12) forming an array (14) to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array, the array being separated from the component by a standoff (18) with a material velocity v_w ; (b) generating a plurality of echo signals using the transducers as receive elements (12); and (c) processing the echo signals in a plurality of channels, said processing comprising:

(i) dynamically focusing the echo signals along the selected ray path on at least one focal point P in the component, wherein said dynamic focusing comprises:

(A) adjusting a delay profile to compensate for refraction of the ultrasonic transmission beam at an interface (22) between the component and the standoff; and

(B) applying the delay profile to the echo signals in the respective channels to generate a plurality of delayed echo signals;

(ii) adjusting the number of active receive elements as a function of a range R_s to provide a dynamic aperture (24) on receive, wherein said adjustment of the number of receive elements comprises compensating for refraction of the ultrasonic transmission beam at the interface between the component and the standoff; and

(iii) summing the delayed echo signals from all of the active receive elements to generate a focused echo signal.

2. The inspection method of Claim 1, wherein said excitement of the transducers (12) comprises applying a separate excitation signal pulse to each of the transducers, said inspection method further comprising:

(d) steering the ultrasonic transmission beam along the selected ray path at an angle $\ominus$ relative to a surface normal (21), said steering comprising:

(i) adjusting a transmit delay profile to com-

pensate for refraction of the ultrasonic transmission beam at the interface between the component and the standoff, the transmit delay profile comprising a plurality of transmit delays, with each transmit delay comprising a static steering term, and (ii) modulating the excitation signal pulses with the transmit delay profile; and

(e) forming a steered focused echo signal by said application of the delay profile to the echo signals in the respective channels to generate the delayed echo signals, wherein said delay profile comprises a plurality of receive delays, with each receive delay comprising a static receive steering term, and wherein said adjustment of the delay profile adjusts each of the static receive steering terms to compensate for refraction at the interface.

3. A method of inspecting a component (10) comprising:

(a) applying a separate excitation pulse to each of a plurality of transducers (12) forming an array (14) to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array, the array being separated from the component by a standoff (18) with a material velocity v_w ; (b) steering the ultrasonic transmission beam along the selected ray path at an angle $\ominus$ relative to a surface normal (21), said steering comprising:

(i) adjusting a transmit delay profile to compensate for refraction of the ultrasonic transmission beam at the interface between the component and the standoff, the transmit delay profile comprising a plurality of transmit delays, each transmit delay comprising a static steering term, and (ii) modulating the excitation pulses with the transmit delay profile;

(c) generating a plurality of echo signals using the transducers as receive elements (12); and (d) processing the echo signals in a plurality of channels using a delay profile, the delay profile comprising a plurality of receive delays, each receive delay comprising a static receive steering term, said processing comprising:

(i) adjusting each of the static receive steering terms to compensate for refraction of the ultrasonic transmission beam at the interface between the component and the standoff;

- (ii) applying the delay profile to the echo signals in the respective channels to generate a plurality of delayed echo signals; and
(iii) summing the delayed echo signals from the receive elements to generate a steered echo signal.
4. The inspection method of Claim 3, wherein said processing step further comprises:
- (iv) adjusting the number of active receive elements (12) as a function of a range R_s to provide a dynamic aperture (24) on receive, wherein said adjustment of the number of receive elements comprises compensating for refraction of the ultrasonic transmission beam at the interface between the component (10) and the standoff (18),
- wherein said summing step comprises summing the delayed echo signals from all of the active receive elements to generate the steered echo signal.
5. A method of inspecting a component (10) along a curved surface (22) of the component and across a standoff (18) with a material velocity v_w , said inspection method comprising:
- (a) adjusting a transmit delay profile to compensate for at least one surface geometry effect, the transmit delay profile comprising a plurality of transmit delays, each of the transmit delays comprising a static surface geometry term;
- (b) modulating a plurality of excitation signal pulses with the transmit delay profile;
- (c) applying the modulated excitation signal pulses to a plurality of transducers (12) forming an array (14) separated from the component by the standoff, to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array;
- (d) generating a plurality of echo signals using the transducers as receive elements (12); and
- (e) processing the echo signals in a plurality of channels, said processing comprising:
- (i) applying a delay profile to the echo signals in the respective channels to generate a plurality of delayed echo signals that compensate for at least one surface geometry effect, the delay profile comprising a plurality of receive delays, each of the receive delays comprising a static surface geometry term; and
- (ii) summing the delayed echo signals from the receive elements to generate a surface geometry effect compensated echo signal.
6. A single-turn method of inspecting a component (10) having an inspection surface (22), said single-turn inspection method comprising:
- (a) positioning an array (14) of transducers (12) facing the inspection surface of the component;
- (b) exciting the transducers to produce an ultrasonic transmission beam focused into the component along a selected ray path (16) from the array;
- (c) generating a plurality of echo signals using the transducers as receive elements (12);
- (d) changing the relative angular orientation of the array and the component around an axis (26) and repeating steps (b) and (c); and
- (e) processing the echo signals in a plurality of channels to form at least one processed echo signal.
7. The single-turn inspection method of Claim 6, wherein the processed echo signals corresponding to a final image of the component (10) are obtained with the relative orientation of the array (14) and the component constrained to rotation around the axis (26).
8. A method of inspecting product flow through a pipe (50), said method comprising:
- (a) exciting a plurality of transducers (12) forming an array (14) to transmit ultrasonic energy into the pipe;
- (b) generating a plurality of receive signals from reflected ultrasonic energy; and
- (c) processing the receive signals in a plurality of channels, said processing comprising comparing the receive signals to a frequency reference to determine a plurality of frequency shifts imparted to the reflected ultrasonic energy.
9. A method of inspecting a component (10) comprising:
- (a) simultaneously exciting a first set of transducers (12) in an array (14);
- (b) receiving a plurality of backscattered ultrasound signals from the component using a second set of transducers (12) in the array as receive elements (12);
- (c) generating a plurality of receive signals from the backscattered ultrasound signals using the receive elements; and
- (d) processing the receive signals to form a set of beam form image data.
10. A method of inspecting a component (10) using a

single array (14) of transducers (12) comprising:

- (a) exciting at least one transmit set of the transducers (12) to produce an ultrasonic transmission beam incident on an inspection surface (22) of the component at an angle $\ominus$ relative to a surface normal (21); 5
- (b) receiving a plurality of back-scattered ultrasound signals from the component using at least one receive set of transducers (12) in the array as receive elements (12), each of the receive and transmit sets being centered at a unique position on the array; 10
- (c) generating a plurality of echo signals from the back-scattered ultrasound signals; and 15
- (d) processing the echo signals in a plurality of channels () to form a set of beam form image data.

20

25

30

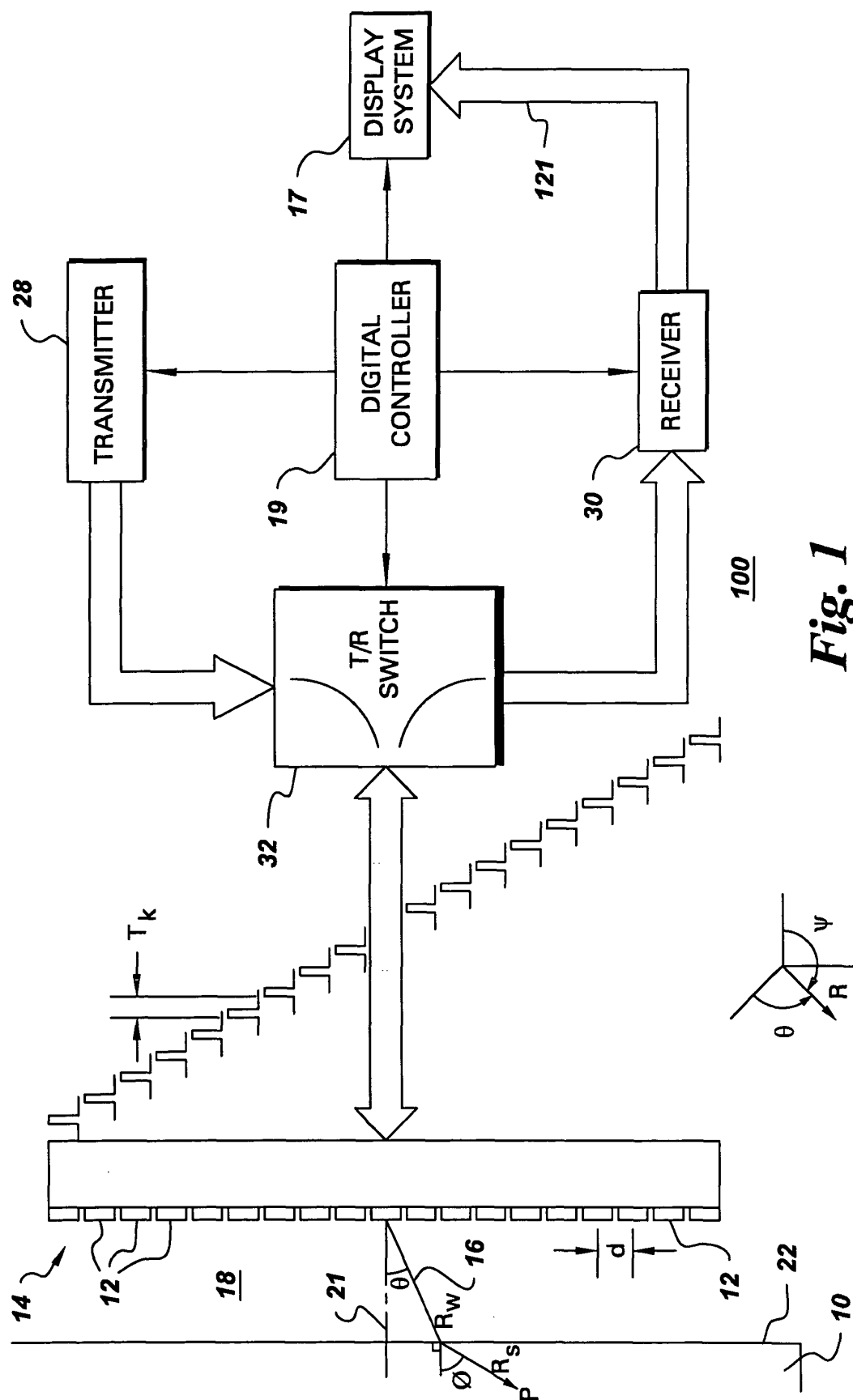
35

40

45

50

55



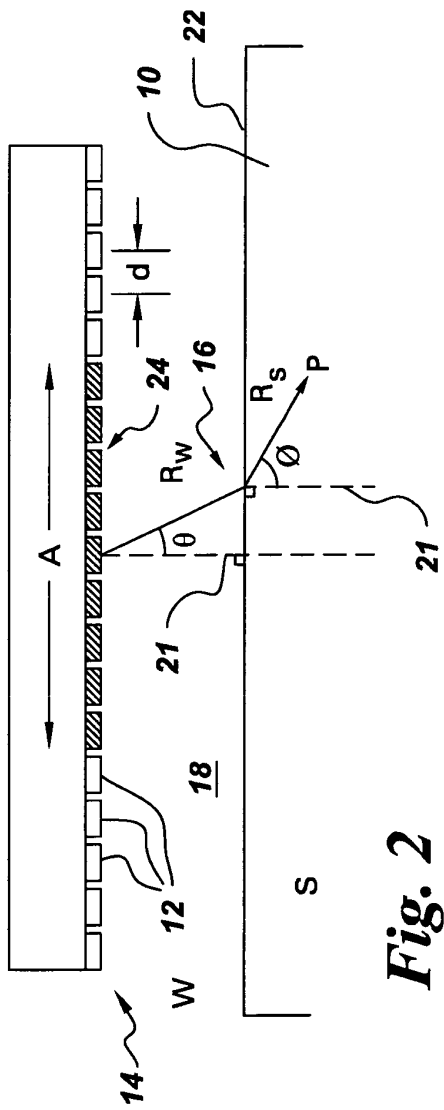


Fig. 2

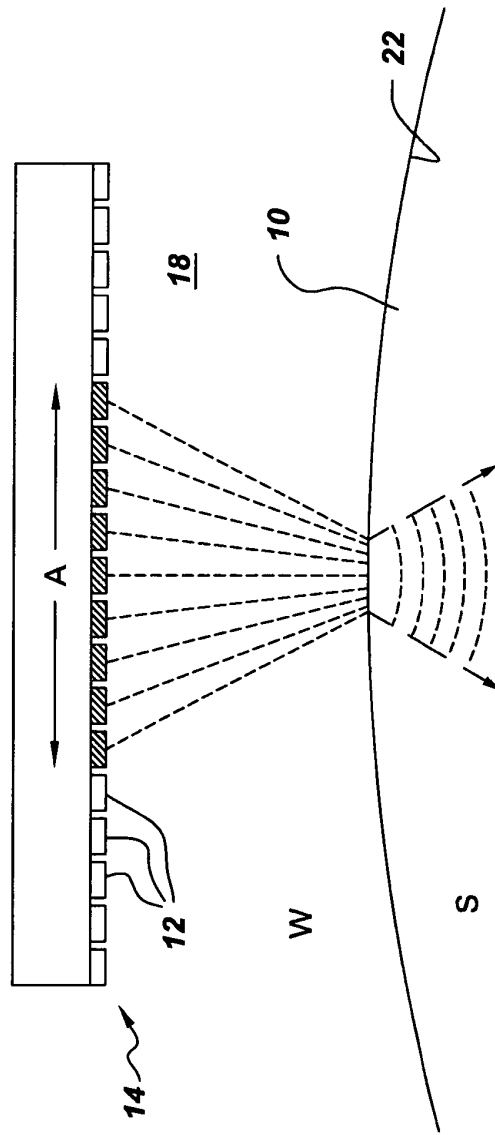


Fig. 3

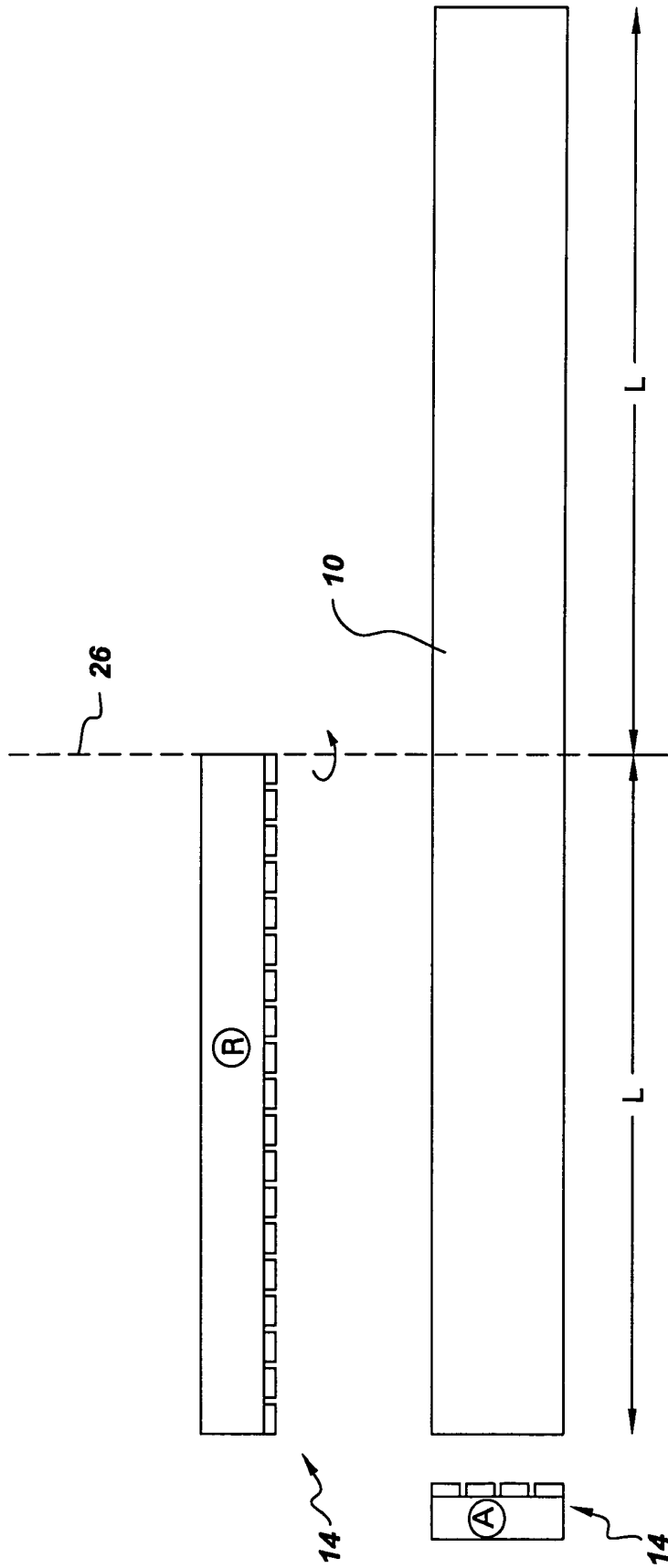


Fig. 4

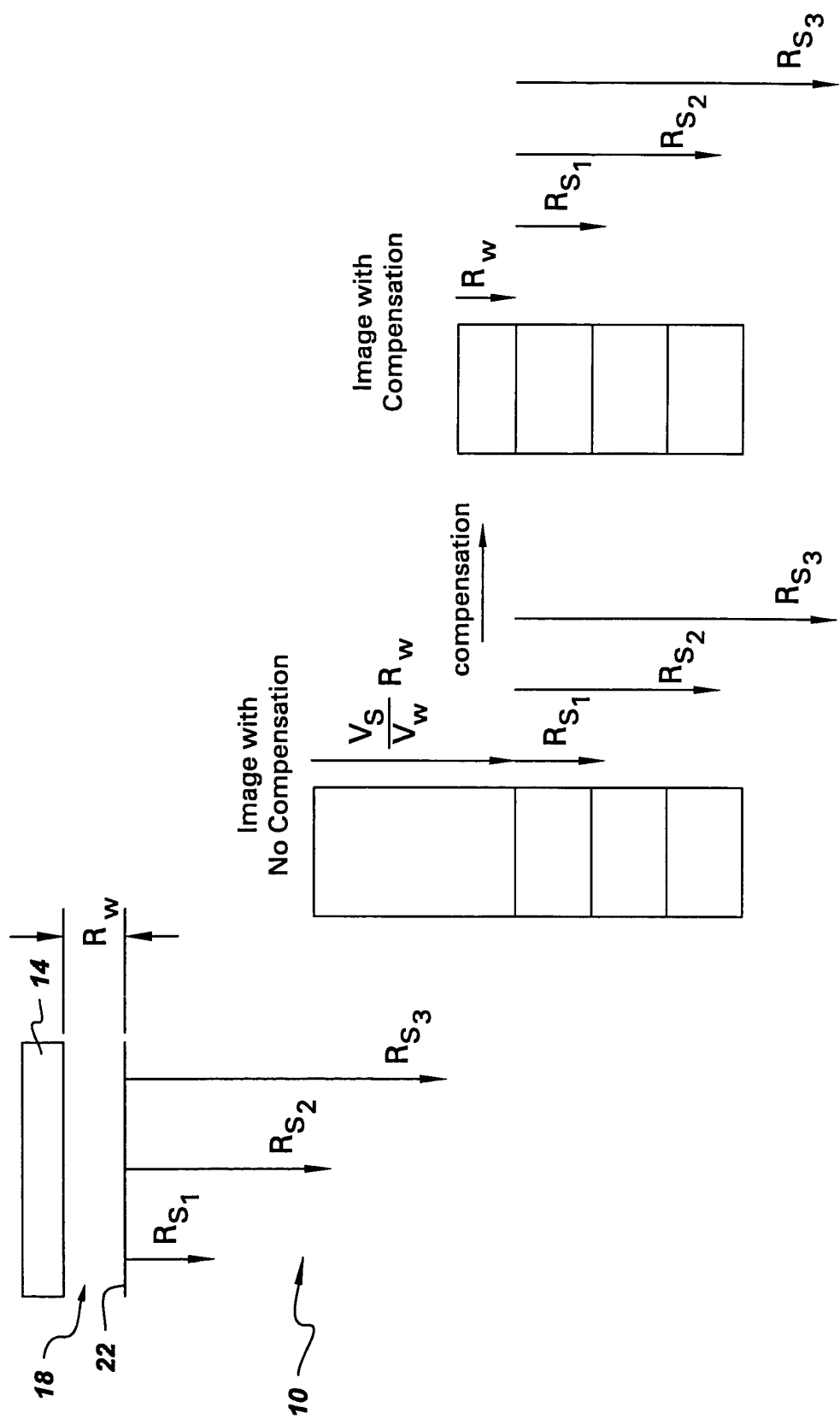


Fig. 5

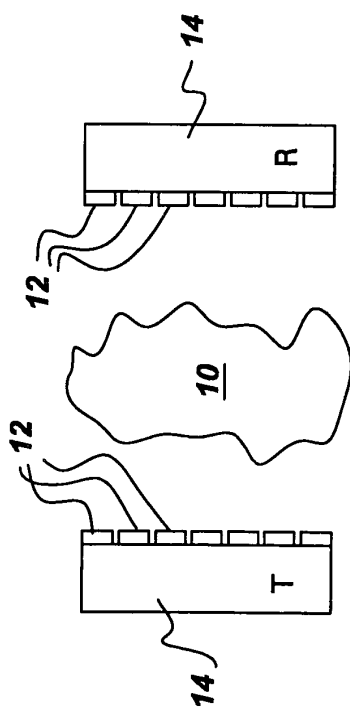


Fig. 6

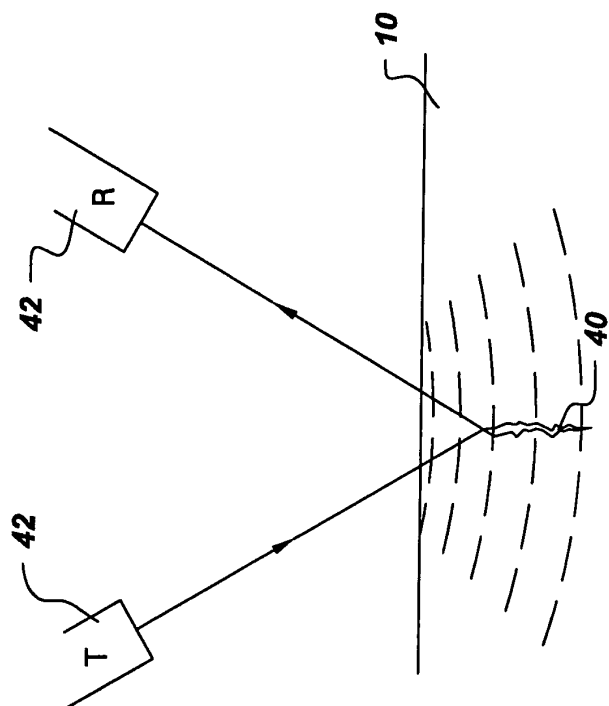


Fig. 7

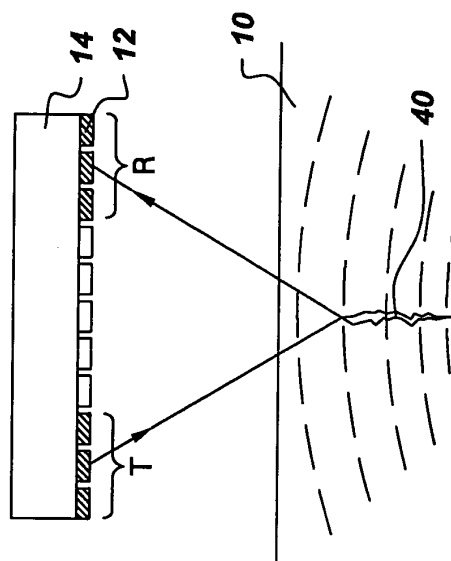
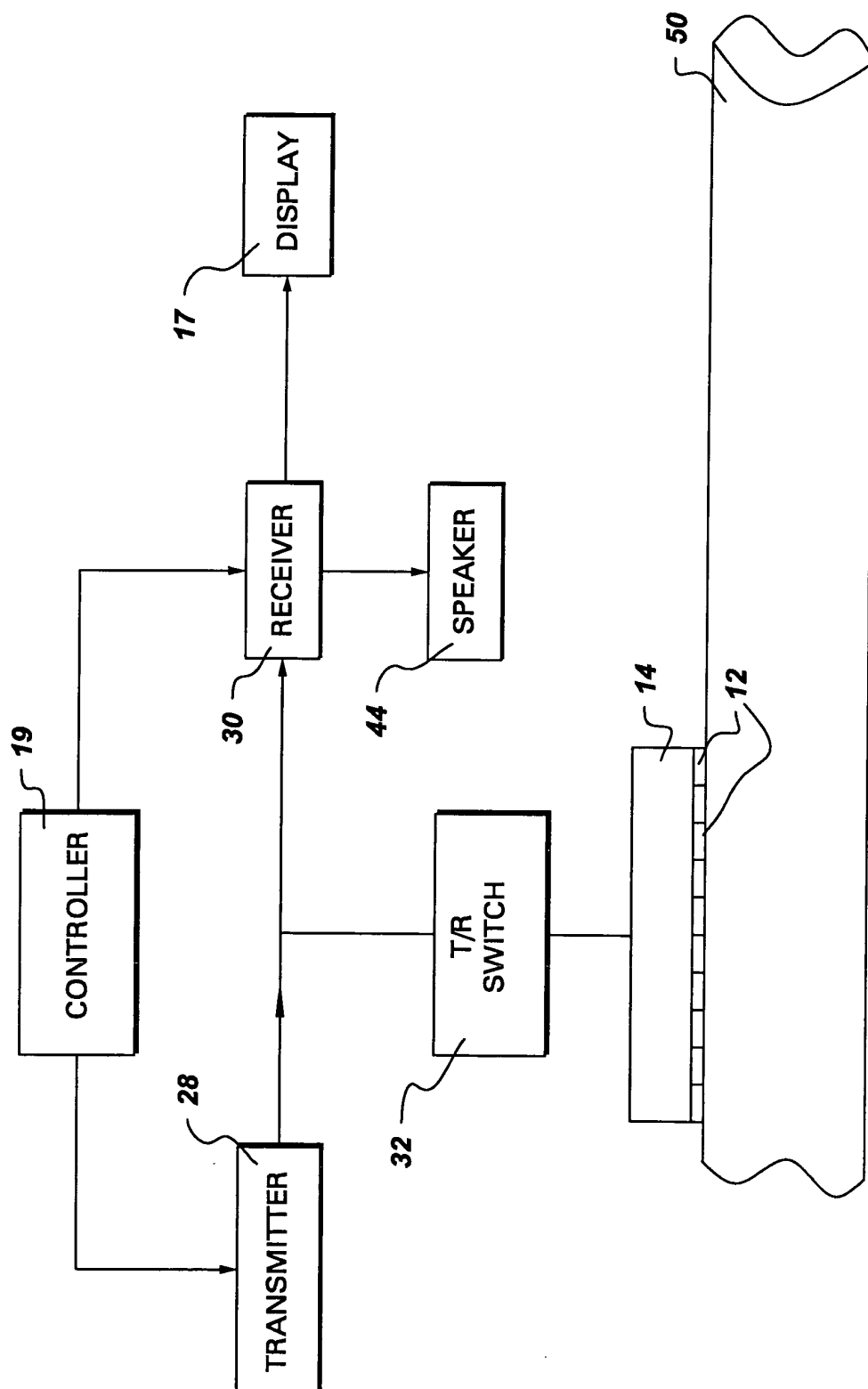
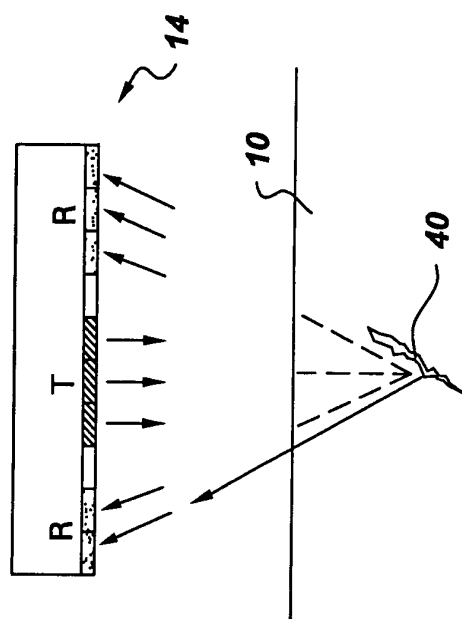
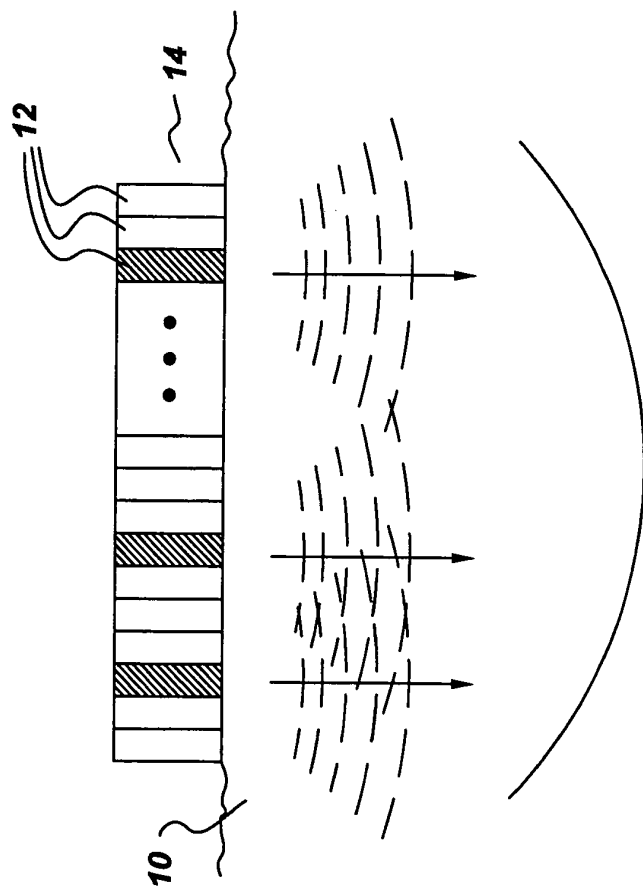


Fig. 8

*Fig. 9*



专利名称(译)	用于工业应用的相控阵超声波检测方法		
公开(公告)号	EP1398627A2	公开(公告)日	2004-03-17
申请号	EP2003255786	申请日	2003-09-16
[标]申请(专利权)人(译)	通用电气公司		
申请(专利权)人(译)	通用电气公司		
当前申请(专利权)人(译)	通用电气公司		
[标]发明人	BATZINGER THOMAS JAMES GILMORE ROBERT SNEE LI WEI NIETERS EDWARD JAMES HATFIELD WILLIAM THOMAS KLAASSEN RICHARD EUGENE BARSHINGER JAMES NORMAN HAIDER BRUNO HANS CHALEK CARL LAWRENCE MCEILLIGOTT ROBERT JOHN FRANKLIN DAVID CHARLES		
发明人	BATZINGER, THOMAS JAMES GILMORE, ROBERT SNEE LI, WEI NIETERS, EDWARD JAMES HATFIELD, WILLIAM THOMAS KLAASSEN RICHARD, EUGENE BARSHINGER, JAMES NORMAN HAIDER, BRUNO HANS CHALEK, CARL LAWRENCE MCEILLIGOTT, ROBERT JOHN FRANKLIN, DAVID CHARLES		
IPC分类号	A61B8/00 G01N29/04 G01N29/06 G01N29/26 G01N29/32 G01N29/34 G01N29/38 G01N29/44 G01S7/523 G01S15/89 G10K11/34 G01S7/52		
CPC分类号	G01N29/4436 G01N29/069 G01N29/262 G01N29/32 G01N29/341 G01N29/38 G01N2291/011 G01N2291/02836 G01N2291/044 G01N2291/048 G01N2291/106 G01S15/8913 G01S15/8918 G01S15/8925 G01S15/894 G01S15/8979 G10K11/346		
优先权	10/244637 2002-09-16 US		
其他公开文献	EP1398627B1 EP1398627A3		
外部链接	Espacenet		

摘要(译)

一种用于检查部件 (10) 的方法包括激励形成阵列 (14) 的多个换能器 (12) , 以产生聚焦到该部件中的超声波发射束 (束) 。阵列和组件由支座 (18) 分开。使用换能器产生许多回波信号, 并且在多个通道中处理回波信号。该处理包括动态聚焦和在接收时提供动态光圈 (24) , 两者都补偿光束在元件/支座接口处的折射。单匝检查方法包括: (a) 使阵列面向组件定位, (b) 激励换能器, (c) 产生多个回波信号, (d) 改变阵列和周围组件的相对角度方向轴 (26) 和重复步骤 (b) 和 (c) , 以及 (e) 处理回波信号以形成至少一个处理后的回波信号。

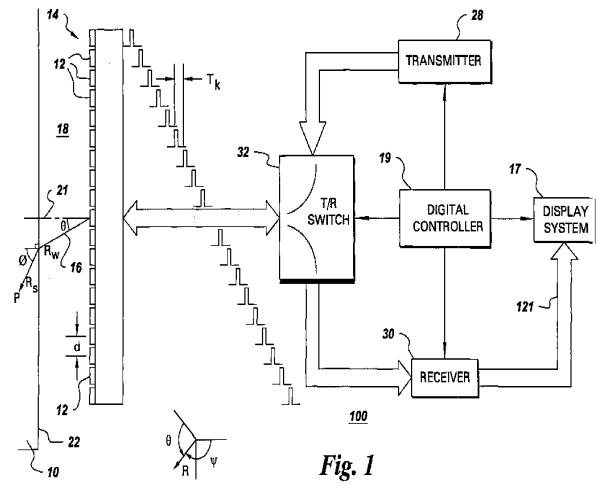


Fig. 1